

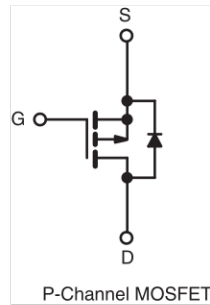
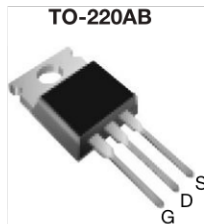
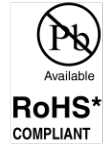
Power MOSFET

PRODUCT SUMMARY

| | | |
|---------------------------|------------------|-----|
| V_{DS} (V) | - 200 | |
| $R_{DS(on)}$ (Ω) | $V_{GS} = -10$ V | 1.5 |
| Q_g (Max.) (nC) | 22 | |
| Q_{gs} (nC) | 12 | |
| Q_{gd} (nC) | 10 | |
| Configuration | Single | |

FEATURES

- Dynamic dV/dt Rating
- P-Channel
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION

| | |
|----------------|-------------|
| Package | TO-220AB |
| Lead (Pb)-free | IRF9620PbF |
| | SiHF9620-E3 |
| SnPb | IRF9620 |
| | SiHF9620 |

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise noted)



| PARAMETER | SYMBOL | LIMIT | UNIT |
|--|------------------|---------------------------|---------------------|
| Drain-Source Voltage | V_{DS} | - 200 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | |
| Continuous Drain Current | I_D | $T_C = 25^\circ\text{C}$ | - 3.5 |
| | | $T_C = 100^\circ\text{C}$ | - 2.0 |
| Pulsed Drain Current ^a | I_{DM} | - 14 | A |
| Linear Derating Factor | | 0.32 | W/ $^\circ\text{C}$ |
| Maximum Power Dissipation | P_D | 40 | W |
| Peak Diode Recovery dV/dt^b | dV/dt | - 5.0 | V/ns |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | - 55 to + 150 | $^\circ\text{C}$ |
| Soldering Recommendations (Peak Temperature) | for 10 s | 300 ^c | |
| Mounting Torque | 6-32 or M3 screw | 10 | |
| | | 1.1 | |

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $I_{SD} \leq -3.5$ A, $dI/dt \leq 95$ A/ μs , $V_{DD} \leq V_{DS}$, $T_J \leq 150^\circ\text{C}$.
- 1.6 mm from case.

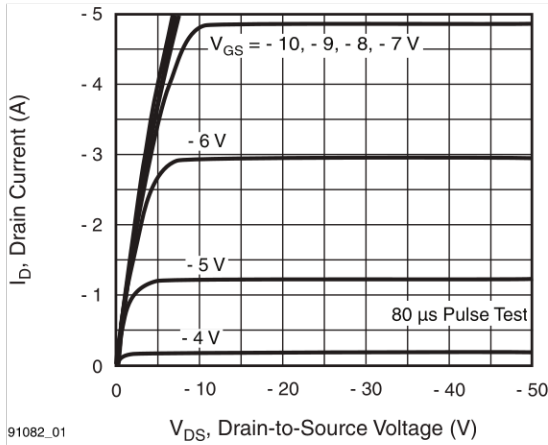
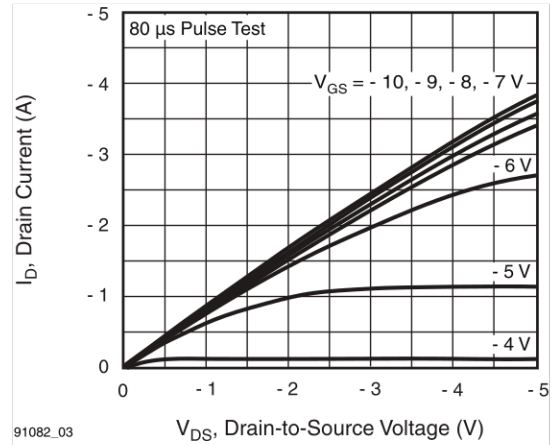
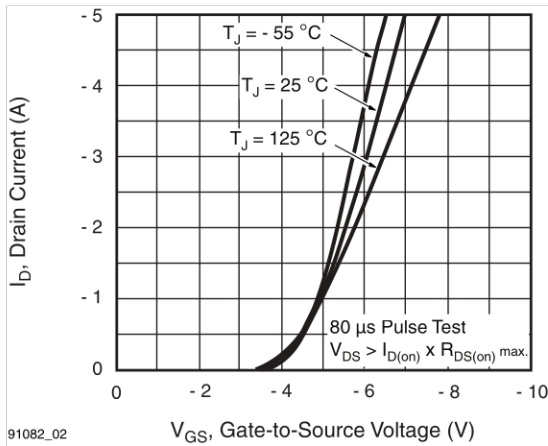
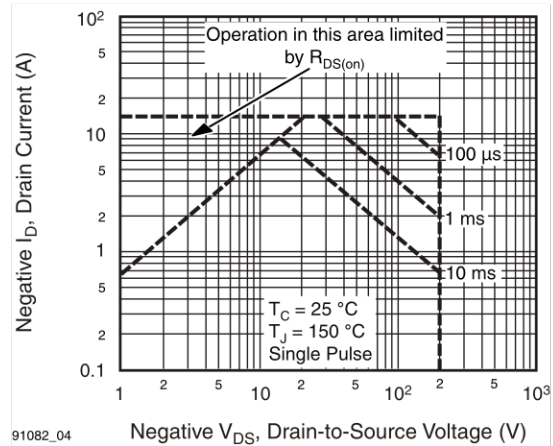
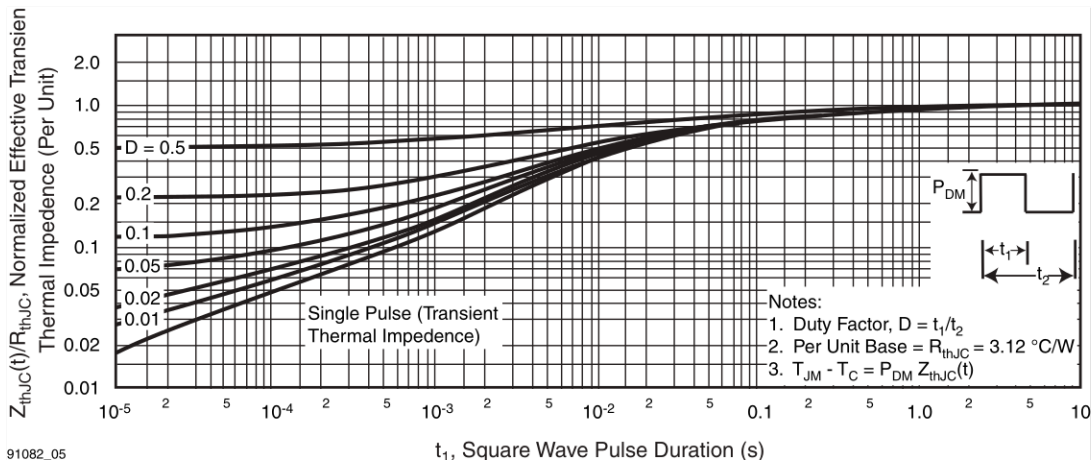
* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS | | | | |
|-------------------------------------|------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R_{thJA} | - | 62 | °C/W |
| Case-to-Sink, Flat, Greased Surface | R_{thCS} | 0.50 | - | |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 3.1 | |

| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | |
|---|---------------------|--|------|-------|-----------|---------------|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$ | -200 | - | - | V |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$, $I_D = -1\text{ mA}$ | - | -0.22 | - | V/°C |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$ | -2.0 | - | -4.0 | V |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 20\text{ V}$ | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -200\text{ V}, V_{GS} = 0\text{ V}$ | - | - | -100 | μA |
| | | $V_{DS} = -160\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | - | - | -500 | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = -10\text{ V}, I_D = -1.5\text{ A}^b$ | - | - | 1.5 | Ω |
| Forward Transconductance | g_{fs} | $V_{DS} = -50\text{ V}, I_D = -1.5\text{ A}^b$ | 1.0 | - | - | S |
| Dynamic | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}, V_{DS} = -25\text{ V}, f = 1.0\text{ MHz}$, see fig. 5 | - | 350 | - | pF |
| Output Capacitance | C_{oss} | | - | 100 | - | |
| Reverse Transfer Capacitance | C_{rss} | | - | 30 | - | |
| Total Gate Charge | Q_g | $V_{GS} = -10\text{ V}, I_D = -4.0\text{ A}, V_{DS} = -160\text{ V}$, see fig. 11 and 18 ^b | - | - | 22 | nC |
| Gate-Source Charge | Q_{gs} | | - | - | 12 | |
| Gate-Drain Charge | Q_{gd} | | - | - | 10 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -100\text{ V}, I_D = -1.5\text{ A}, R_g = 50\text{ }\Omega, R_D = 67\text{ }\Omega$, see fig. 17 ^b | - | 15 | - | ns |
| Rise Time | t_r | | - | 25 | - | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 20 | - | |
| Fall Time | t_f | | - | 15 | - | |
| Internal Drain Inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact  | - | 4.5 | - | nH |
| Internal Source Inductance | L_S | | - | 7.5 | - | |
| Drain-Source Body Diode Characteristics | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | -3.5 | A |
| Pulsed Diode Forward Current ^a | I_{SM} | | - | - | -14 | |
| Body Diode Voltage | V_{SD} | $T_J = 25\text{ }^\circ\text{C}, I_S = -3.5\text{ A}, V_{GS} = 0\text{ V}^b$ | - | - | -7.0 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = -3.5\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}^b$ | - | 300 | 450 | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | - | 1.9 | 2.9 | μC |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics

Fig. 3 - Typical Saturation Characteristics

Fig. 2 - Typical Transfer Characteristics

Fig. 4 - Maximum Safe Operating Area

Fig. 5 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

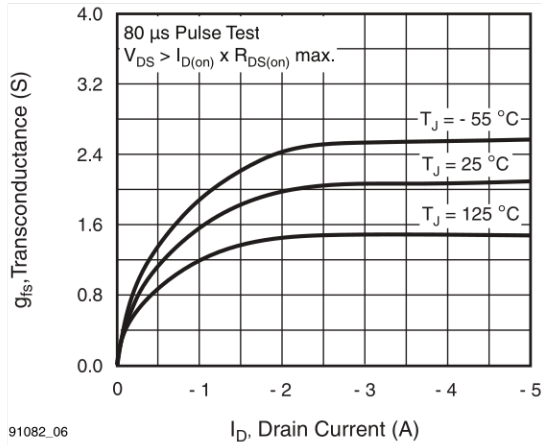


Fig. 6 - Typical Transconductance vs. Drain Current

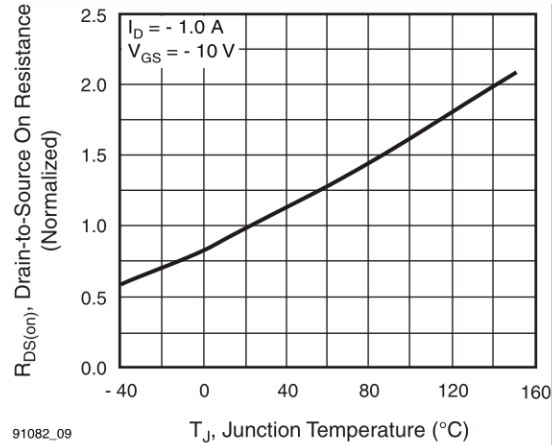


Fig. 9 - Normalized On-Resistance vs. Temperature

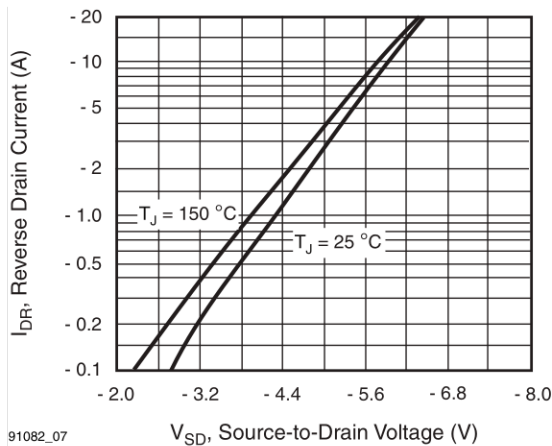


Fig. 7 - Typical Source-Drain Diode Forward Voltage

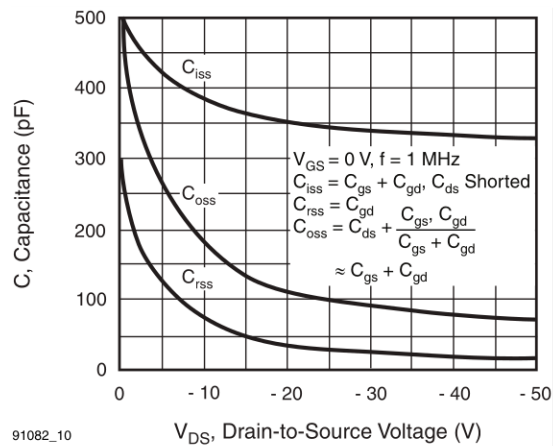


Fig. 10 - Typical Capacitance vs. Drain-to-Source Voltage

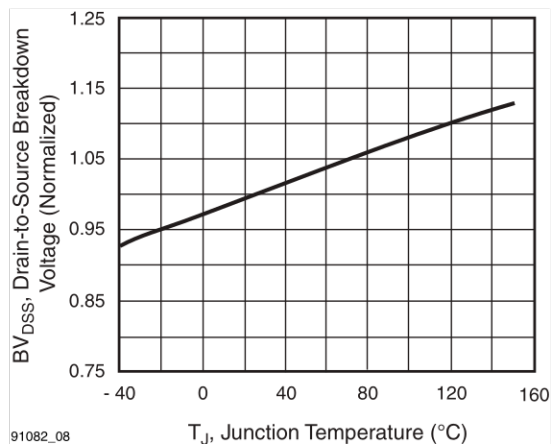


Fig. 8 - Breakdown Voltage vs. Temperature

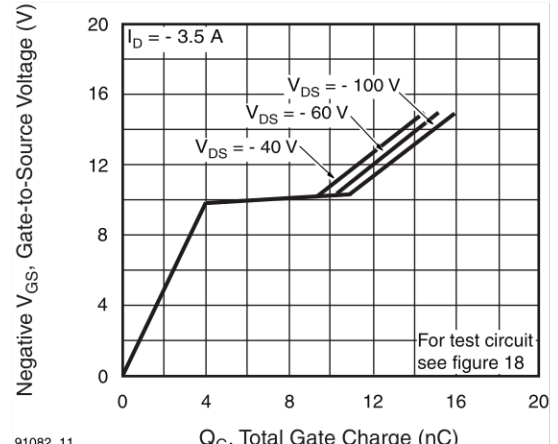
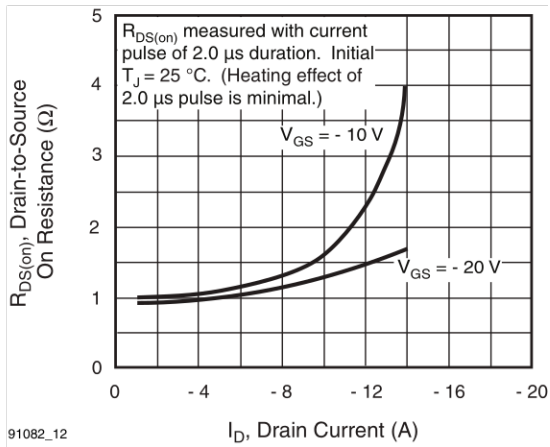
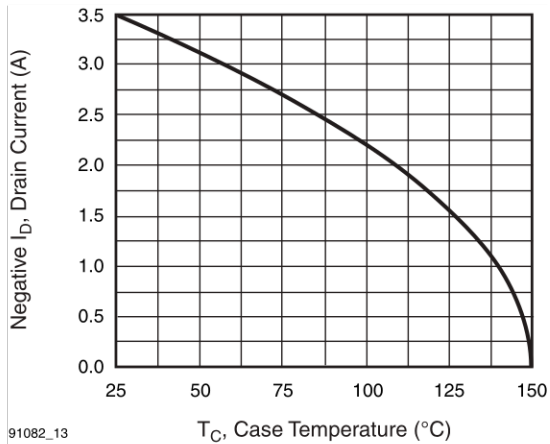


Fig. 11 - Typical Gate Charge vs. Gate-to-Source Voltage



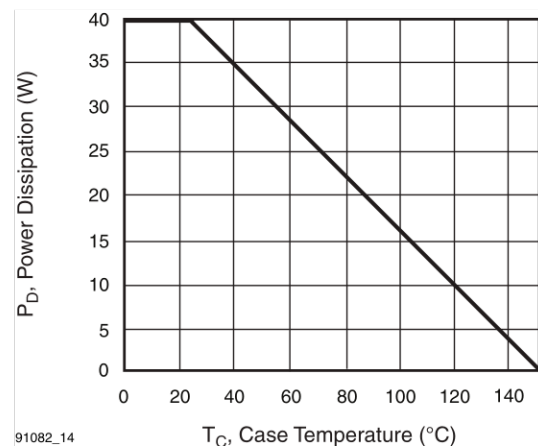
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Fig. 12 - Typical On-Resistance vs. Drain Current



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Fig. 13 - Maximum Drain Current vs. Case Temperature



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Fig. 14 - Power vs. Temperature Derating Curve

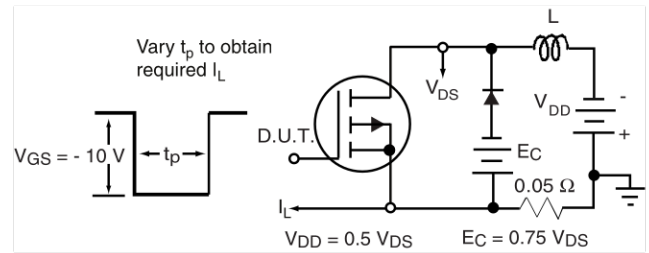


Fig. 15 - Clamped Inductive Test Circuit

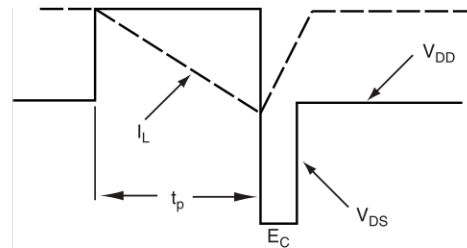


Fig. 16 - Clamped Inductive Waveforms

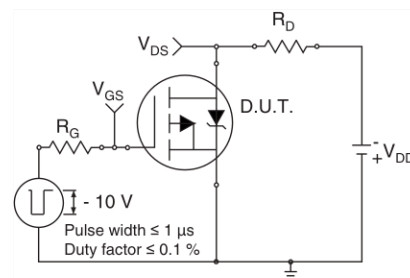


Fig. 17a - Switching Time Test Circuit

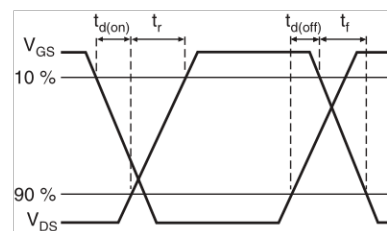


Fig. 17b - Switching Time Waveforms

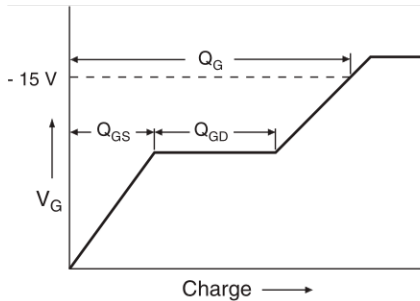


Fig. 18a - Basic Gate Charge Waveform

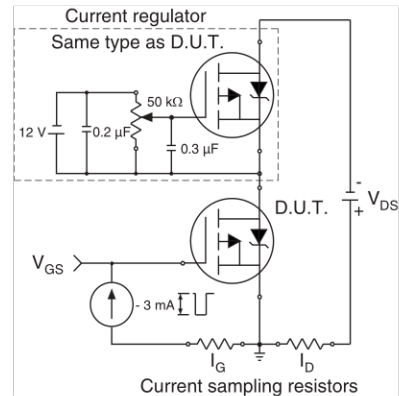


Fig. 18b - Gate Charge Test Circuit

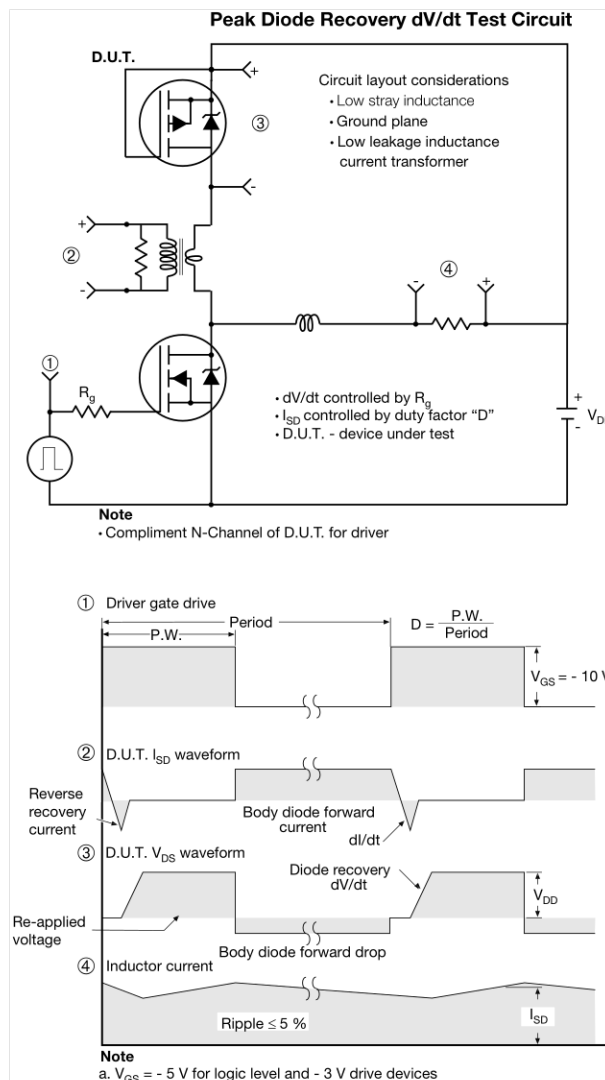
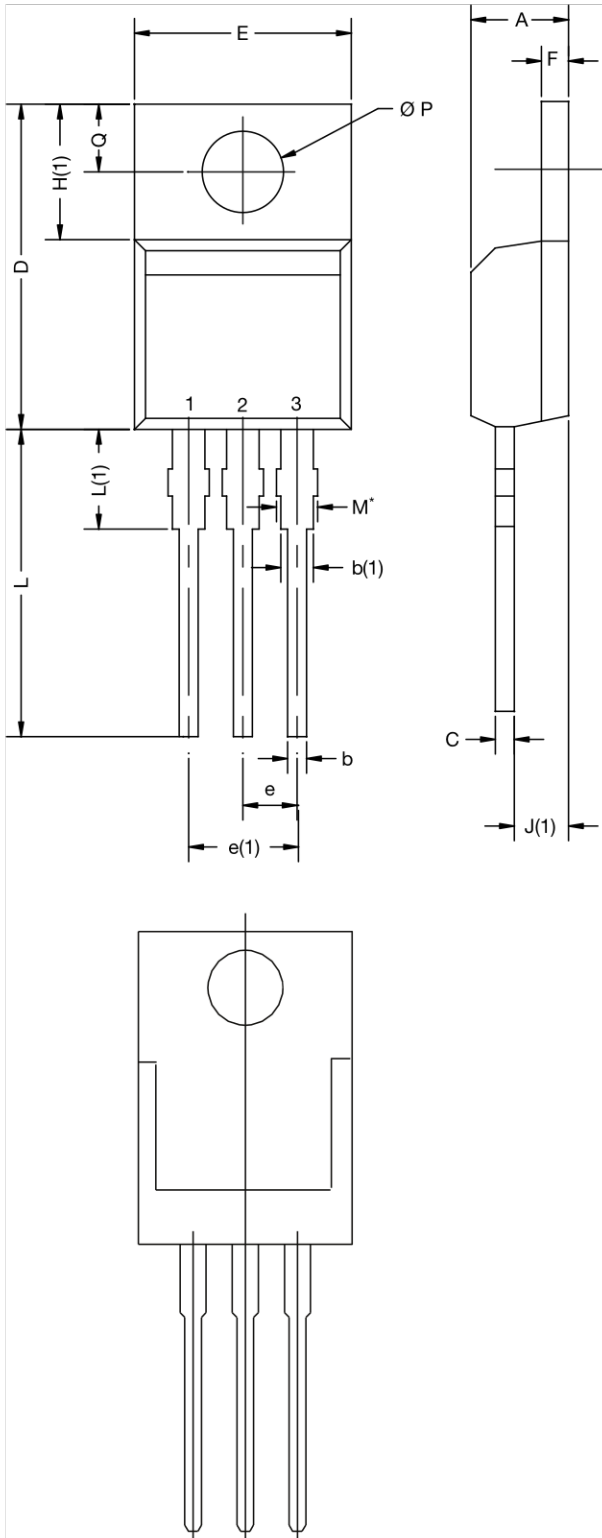


Fig. 19 - For P-Channel

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TO-220-1



| DIM. | MILLIMETERS | | INCHES | |
|-----------------|-------------|-------|--------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A | 4.14 | 4.70 | 0.163 | 0.185 |
| b | 0.69 | 1.02 | 0.027 | 0.040 |
| b(1) | 1.14 | 1.73 | 0.045 | 0.068 |
| c | 0.36 | 0.61 | 0.014 | 0.024 |
| D | 14.33 | 15.85 | 0.564 | 0.624 |
| E | 9.96 | 10.52 | 0.392 | 0.414 |
| e | 2.41 | 2.67 | 0.095 | 0.105 |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 |
| F | 0.43 | 1.40 | 0.017 | 0.055 |
| H(1) | 6.10 | 6.48 | 0.240 | 0.255 |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 |
| L | 13.36 | 14.40 | 0.526 | 0.567 |
| L(1) | 3.33 | 4.04 | 0.131 | 0.159 |
| $\varnothing P$ | 3.53 | 3.94 | 0.139 | 0.155 |
| Q | 2.59 | 3.00 | 0.102 | 0.118 |

ECN: X15-0003-Rev. A, 19-Jan-15
 DWG: 6031

Notes

- M^* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM
- Outline conforms to JEDEC® outline TO-220AB with exception of dimension F



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